Detection



Nexera Application Data Sheet No. 5

Impurity Analysis by High-sensitivity UV Detector

Analysis of impurities can be a challenging task especially when the main ingredient needs to be assayed at the same time, which requires a wider dynamic range and lower baseline disturbances. With an extra wide dynamic range, temperature-controlled flow cell and a stray-light correction function, both SPD-20A UV and SPD-M20A Photo Diode Array detectors offer a high level of stability, sensitivity and linearity for a confident analysis. The 100 Hz sampling of the SPD-20A/M20A ensures peak information can be captured without loss of resolution and exploits the full potential of ultra-fast LC columns.



As shown below the SPD-20A UV detector could detect the impurities 0.05 % relative to the main compound with good reproducibility.

0.00



UV 240 nm

Repeatability	/ of I	neak	area ((%)	RSD	n=6)
repeatabilit	ן וט ע	pear	area, i	01	NOD,	11-0)

0.25 0.50 0.75 1.00 1.25 1.50 1.75 2.00 2.25 2.50 2.75 min

	impurity content (%)					
	0.005 %	0.05%	0.5%			
Impurity 1	2.22	0.73	0.16			
Impurity 2	2.55	0.89	0.19			

